

# IEEE802.3bt PSE Rsense Noise Margin

J. Heath – Linear Technology



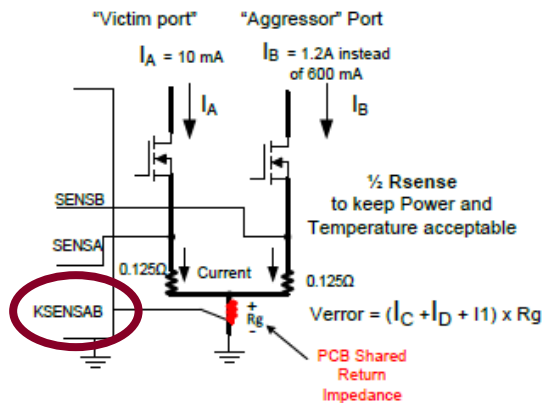
## Goal of this Presentation

- Clarify and correct  $R_{sense}$  common resistance statements from Indian Wells TI presentation [picard\\_1\\_0114.pdf](#)

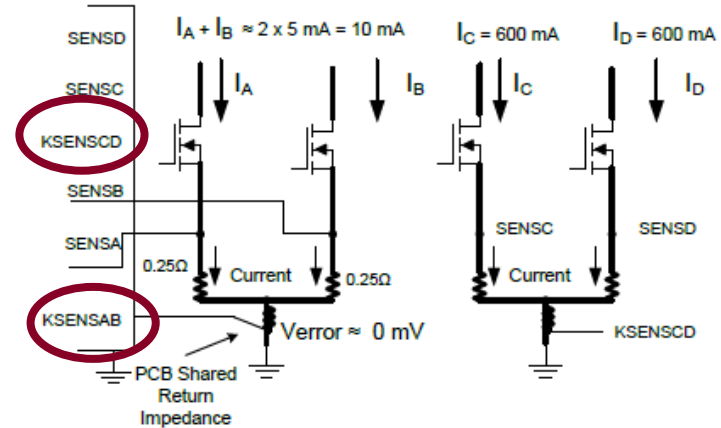
The slide indicates that there is zero common mode error with 2xN architectures and 0.625mV of error with an equivalent 1xN architecture

- The problem with this conclusion is the common resistance assumptions are incorrect

- Example if **1-power channel** solution:  $0.125 \text{ ohm} \times 10\text{mA} = 1.25 \text{ mV}$ . If the "victim" port shares same return impedance with **one** 1.2A aggressor port, only 0.52 mohm can result in **+ 0.625mV error**



Single-PSE power channel solution

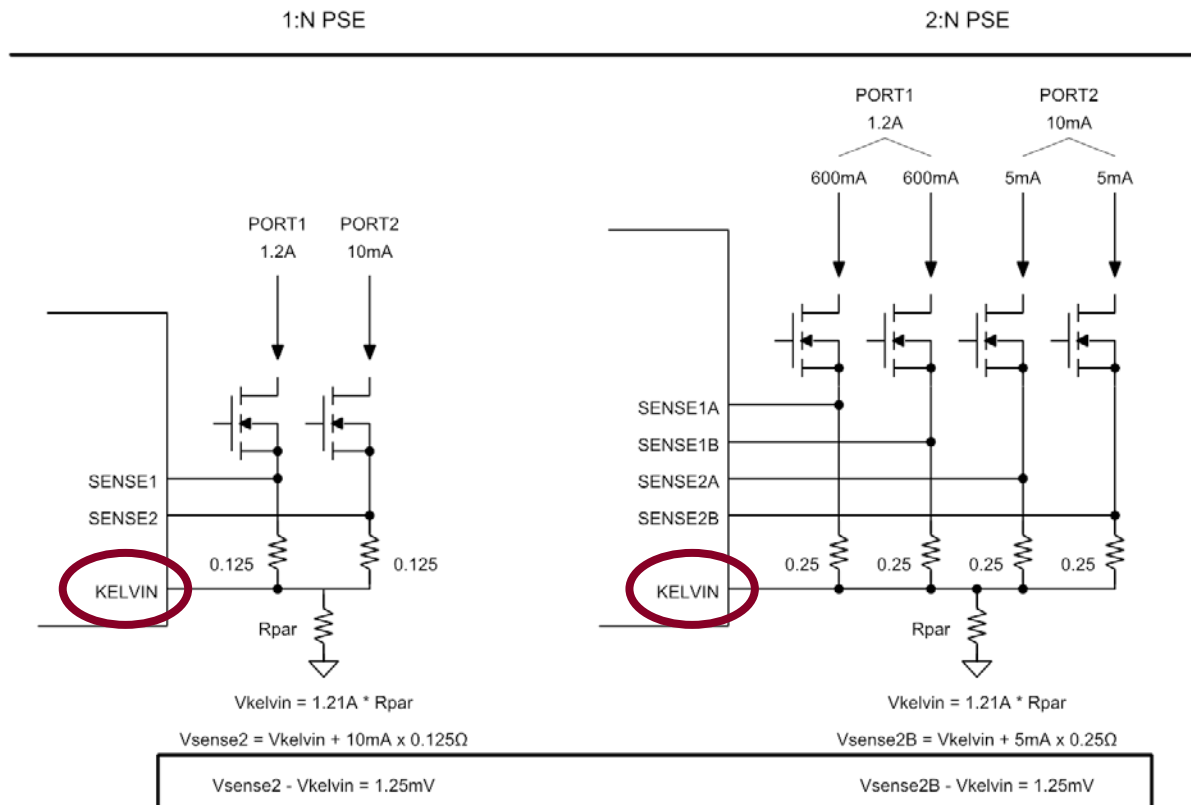


2-PSE power channel solution



# This is an apples to apples comparison

- Here is the math using the same number of Kelvin Connections



## Conclusions

- There is no difference in the difficulty measuring DC Disconnect between 2xN and 1xN PSE topologies due to equal common resistance and the same number of Kelvin connections per channel